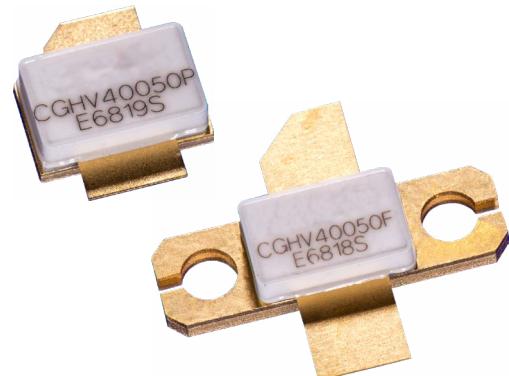


# CGHV40050

50 W, DC - 4.0 GHz, 50 V, GaN HEMT

## Description

The CGHV40050 is an unmatched, gallium nitride (GaN) high electron mobility transistor (HEMT). The CGHV40050, operating from a 50 volt rail, offers a general purpose, broadband solution to a variety of RF and microwave applications up to 4 GHz. The reference HPA design in the datasheet operates from 800 MHz to 2 GHz operation instantaneously. It is a demonstration amplifier to showcase the CGHV40050's high efficiency, high gain and wide bandwidth capabilities. The device can be used for a range of applications from narrow band UHF, L and S Band as well as multi-octave bandwidth amplifiers up to 4 GHz. The transistor is available in a 2-lead flange and pill package.



Package Types: 440193 & 440206  
PNs: CGHV40050F & CGHV40050P

## Typical Performance Over 800 MHz - 2.0 GHz ( $T_c = 25^\circ\text{C}$ ), 50 V

Parameter	800 MHz	1.2 GHz	1.4 GHz	1.8 GHz	2.0 GHz	Units
Small Signal Gain	17.6	16.9	17.7	17.5	14.8	dB
Saturated Output Power	65	70	63	77	60	W
Drain Efficiency @ $P_{\text{SAT}}$	63	63	60	53	52	%
Input Return Loss	5	5.5	4.2	8	5	dB

Note: Measured CW in the CGHV40050F-AMP application circuit.

## Features

- Up to 4 GHz Operation
- 77 W Typical Output Power
- 17.5 dB Small Signal Gain at 1.8 GHz
- Application Circuit for 0.8 - 2.0 GHz
- 53% Efficiency at  $P_{\text{SAT}}$
- 50 V Operation



Large Signal Models Available for ADS and MWO



**Absolute Maximum Ratings (not simultaneous) at 25°C Case Temperature**

Parameter	Symbol	Rating	Units	Conditions
Drain-Source Voltage	$V_{DSS}$	150	V	25°C
Gate-to-Source Voltage	$V_{GS}$	-10, +2		
Storage Temperature	$T_{STG}$	-65, +150	°C	
Operating Junction Temperature	$T_J$	225		
Maximum Forward Gate Current	$I_{GMAX}$	10.4	mA	25°C
Maximum Drain Current <sup>1</sup>	$I_{DMAX}$	6.3	A	
Soldering Temperature <sup>2</sup>	$T_S$	245	°C	
Screw Torque	$\tau$	40	in-oz	
Thermal Resistance, Junction to Case <sup>3</sup>	$R_{θJC}$	3.04	°C/W	85°C
Thermal Resistance, Junction to Case <sup>4</sup>		3.11		
Case Operating Temperature <sup>5</sup>	$T_c$	-40, +80	°C	30 Seconds

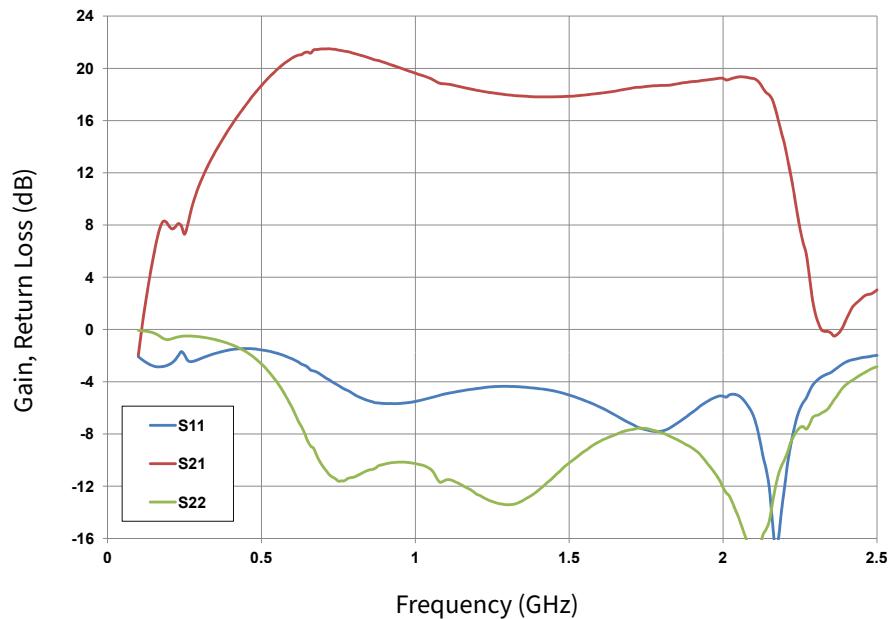
## Notes:

<sup>1</sup> Current limit for long term, reliable operation<sup>2</sup> Refer to the Application Note on soldering<sup>3</sup> Measured for the CGHV40050P at  $P_{DISS} = 41.6$  W<sup>4</sup> Measured for the CGHV40050F at  $P_{DISS} = 41.6$  W<sup>5</sup> See also, Power Derating Curve on Page 7**Electrical Characteristics ( $T_c = 25^\circ\text{C}$ )**

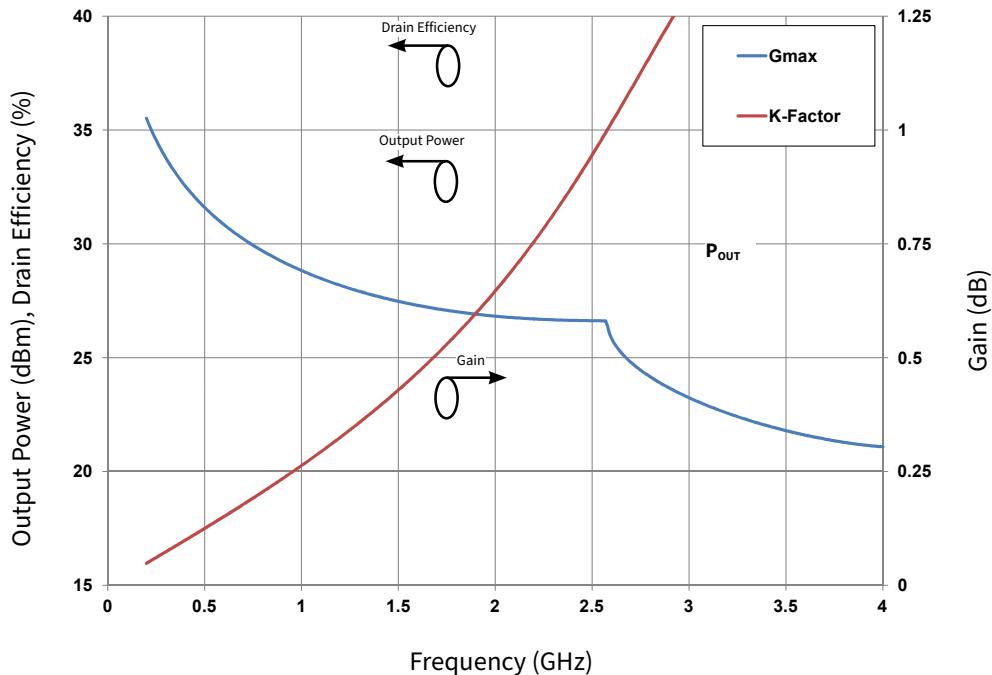
Characteristics	Symbol	Min.	Typ.	Max.	Units	Conditions
<b>DC Characteristics<sup>1</sup></b>						
Gate Threshold Voltage	$V_{GS(\text{th})}$	-3.8	-3.0	-2.3	V <sub>DC</sub>	$V_{DS} = 10$ V, $I_D = 10.4$ mA
Gate Quiescent Voltage	$V_{GS(Q)}$	—	-2.7	—		$V_{DS} = 50$ V, $I_D = 0.3$ A
Saturated Drain Current <sup>2</sup>	$I_{DS}$	6.8	9.7	—	A	$V_{DS} = 6.0$ V, $V_{GS} = 2.0$ V
Drain-Source Breakdown Voltage	$V_{BR}$	100	—	—		$V_{GS} = -8$ V, $I_D = 10.4$ mA
<b>RF Characteristics<sup>3</sup> (<math>T_c = 25^\circ\text{C}</math>, <math>F_0 = 1.8</math> GHz unless otherwise noted)</b>						
Small Signal Gain	$G_{SS}$	17.5	19	—	dB	$V_{DD} = 50$ V, $I_{DQ} = 0.3$ A
Power Gain	$G_P$	—	15.5	—		$V_{DD} = 50$ V, $I_{DQ} = 0.3$ A, $P_{OUT} = P_{SAT}$
Output Power at Saturation <sup>4</sup>	$P_{SAT}$	70	77	—	W	$V_{DD} = 50$ V, $I_{DQ} = 0.3$ A
Drain Efficiency	$\eta$	48	53	—	%	$V_{DD} = 50$ V, $I_{DQ} = 0.3$ A, $P_{OUT} = P_{SAT}$
Output Mismatch Stress	VSWR	—	—	10:1	$\Psi$	No damage at all phase angles, $V_{DD} = 50$ V, $I_{DQ} = 0.3$ A, $P_{OUT} = 50$ W CW
<b>Dynamic Characteristics</b>						
Input Capacitance	$C_{GS}$	—	16	—	pF	$V_{DS} = 50$ V, $V_{GS} = -8$ V, $f = 1$ MHz
Output Capacitance	$C_{DS}$	—	5	—		
Feedback Capacitance	$C_{GD}$	—	0.3	—		

## Notes:

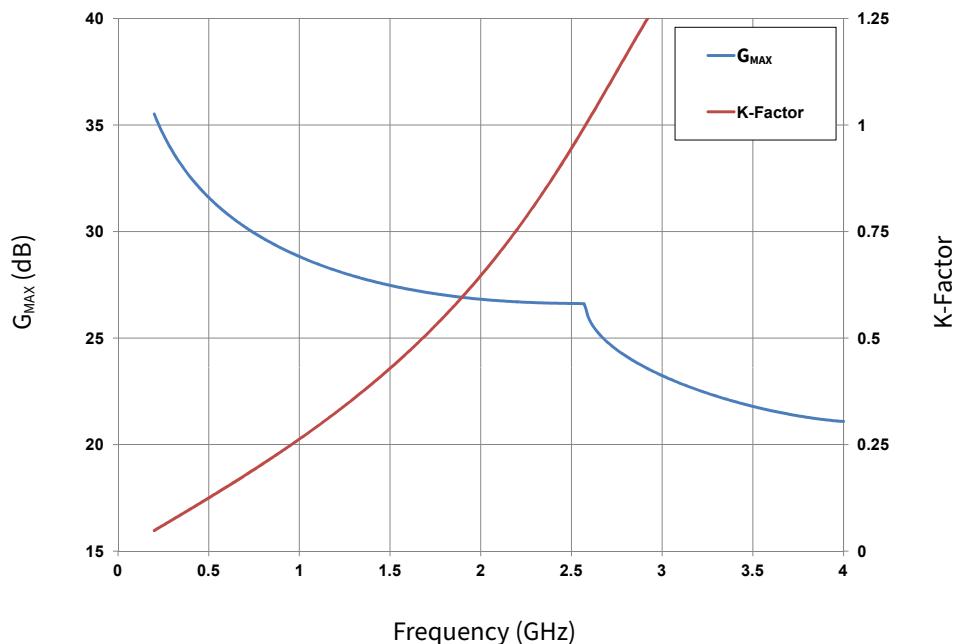
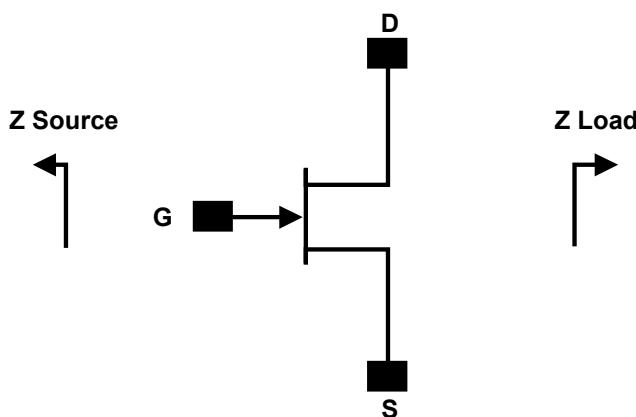
<sup>1</sup> Measured on wafer prior to packaging.<sup>2</sup> Scaled from PCM data<sup>3</sup> Measured in CGHV40050-AMP<sup>4</sup>  $P_{SAT}$  is defined as  $I_G = 1$  mA<sup>5</sup> Includes package

**CGHV40050 Typical Performance**

**Figure 1.** Small Signal Gain and Return Losses vs Frequency of the CGHV40050 in the application circuit CGHV40050-AMP  
 $V_{DD} = 50$  V,  $I_{DQ} = 300$  mA,  $T_{CASE} = 25^\circ\text{C}$

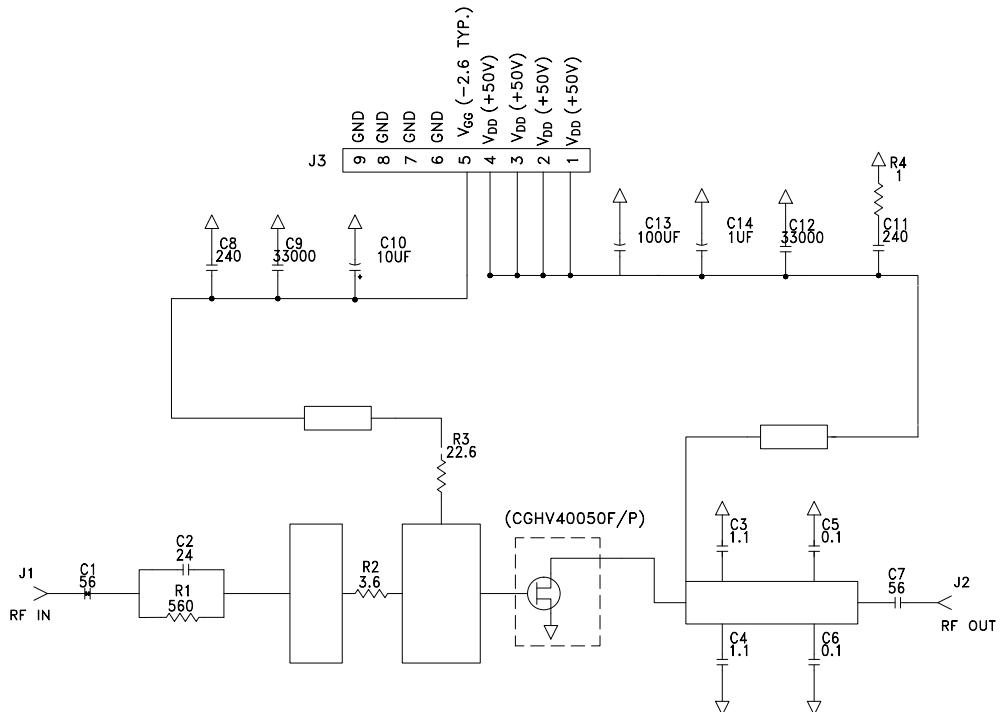
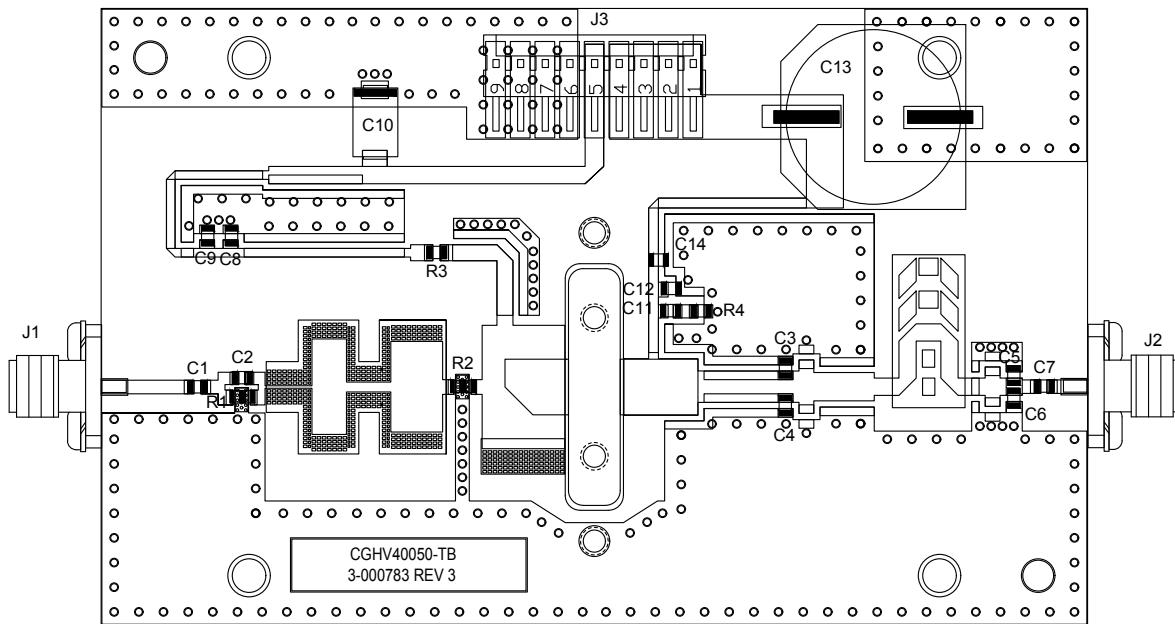


**Figure 2.** Gain, Output Power and Drain Efficiency vs Frequency of the CGHV40050 measured in Broadband Amplifier Circuit CGHV40050-AMP  
 $V_{DD} = 50$  V,  $I_{DQ} = 300$  mA,  $T_{CASE} = 25^\circ\text{C}$

**CGHV40050 Typical Performance****Figure 3.  $G_{MAX}$  and K-Factor vs Frequency** $V_{DD} = 50V, I_{DQ} = 300\text{ mA}, T_{CASE} = 25^\circ\text{C}$ **Source and Load Impedances**

Frequency (MHz)	$Z_{Source}$	$Z_{Load}$
500	$5.69+j7.82$	$21.47+j10.28$
1000	$3.21+j3.48$	$11.72+j10.50$
2000	$3.2-j1.74$	$3.84+j7.07$
3000	$3.23-j5.23$	$5.58+j3.02$
4000	$2.75-j10.6$	$4.65-j0.74$

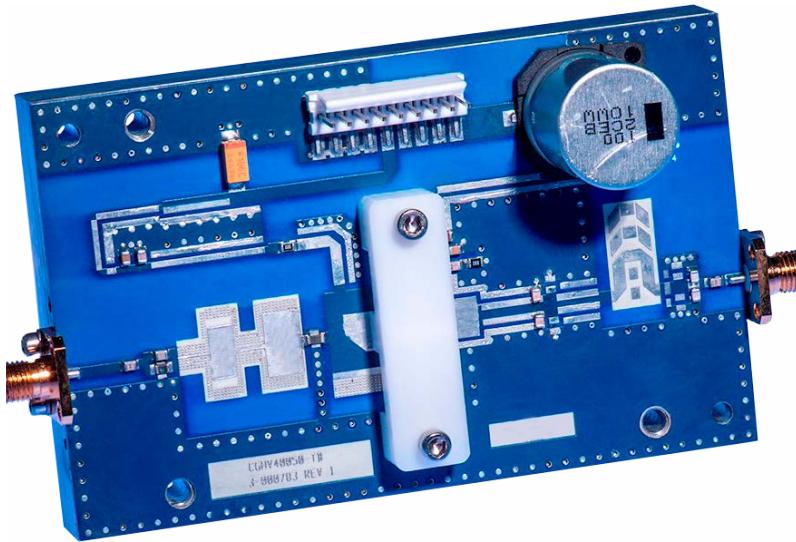
Note:  $V_{DD} = 50V, I_{DQ} = 300\text{ mA}$  in the 440193 package

**CGHV40050-AMP Application Circuit Schematic****CGHV40050-AMP Application Circuit**

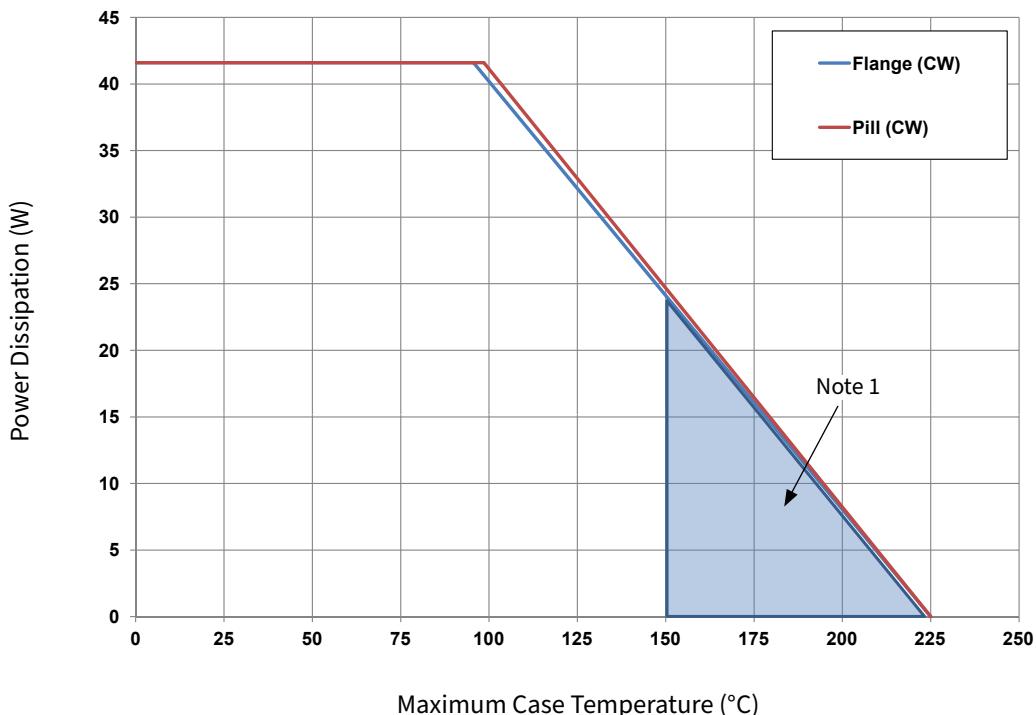
## CGHV40050-AMP Application Circuit Bill of Materials

Designator	Description	Qty
R1	RES, 560 Ohms, 0805, HIGH POWER SMT	1
R2	RES, 3.6 Ohms, 1005, HIGH POWER SMT	1
R3	RES, SMT, 0805, 22 OHM	1
R4	RES, SMT, 0805, 1 OHM	1
C1, C7	CAP, 56pF +/- 5%, 250V, 0805, ATC 600F	3
C2	CAP, 24pF +/- 5%, 250V, 0805, ATC 600F	1
C3, C4	CAP, 1.1pF, +/- 0.1pF, 250V, 0805, ATC600F	2
C5, C6	CAP, 0.1pF +/- 0.05pF, 0805, ATC 600F	2
C8, C11	CAP, 240pF, +/-5%, 0805, ATC600F	2
C9, C12	CAP, 33000pF, 0805, 100V, X7R	2
C10	CAP, 10µF, 16V, TANTALUM	1
C13	CAP, 100µF, 80V, ELECTROLYTIC, CAN	1
C14	CAP, 1µF, 0805, 100V, X7S	1
J1,J2	CONN, SMA, PANEL MOUNT JACK, FLANGE, 4-HOLE, BLUNT POST	2
J3	HEADER RT>PLZ .1CEN LK 9POS	1
-	BASEPLATE, CGH35120	1
-	PCB, RO4350B, 2.5"x4"x0.020", CGHV40050F	1

## CGHV40050-AMP Demonstration Amplifier Circuit



## CGHV40050 Power Dissipation De-rating Curve



**Figure 4.** Transient Power Dissipation De-Rating Curve

Note:

<sup>1</sup> Area exceeds Maximum Case Operating Temperature (See Page 2).

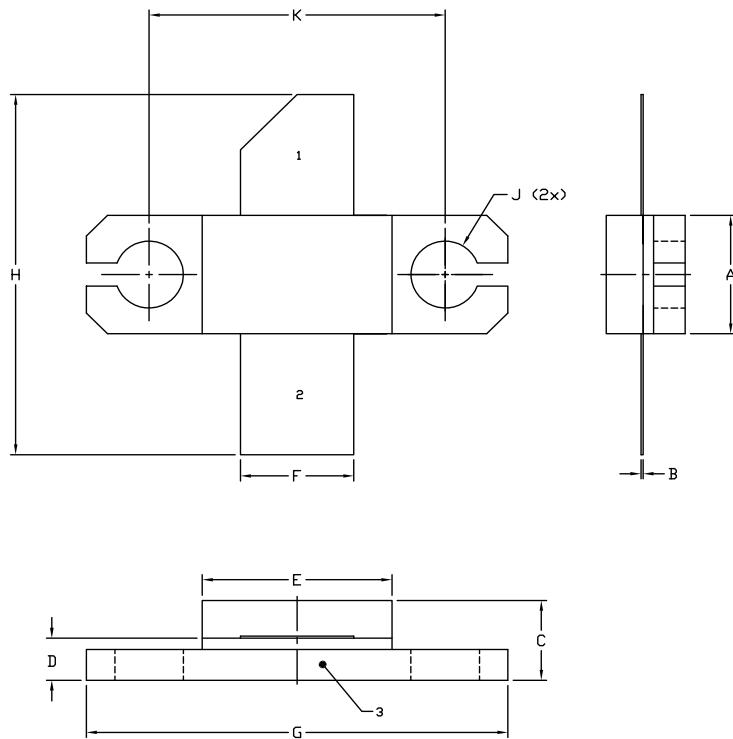
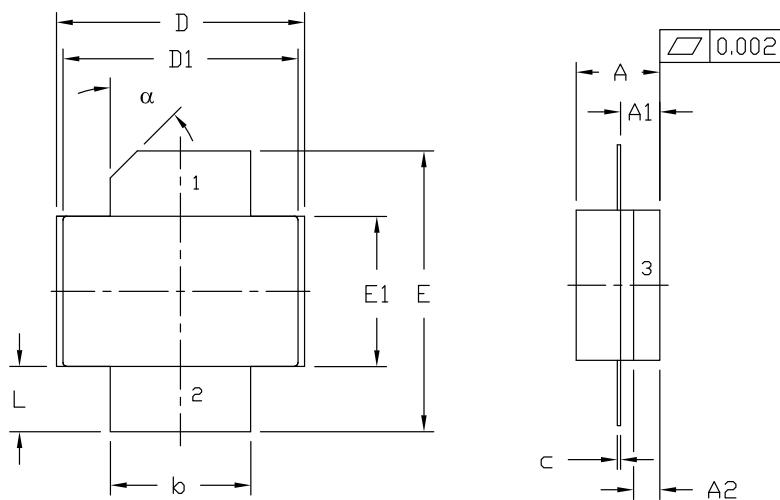
## Electrostatic Discharge (ESD) Classifications

Parameter	Symbol	Class	Classification Level	Test Methodology
Human Body Model	HBM	TBD	ANSI/ESDA/JEDEC JS-001 Table 3	JEDEC JESD22 A114-D
Charge Device Model	CDM	TBD	ANSI/ESDA/JEDEC JS-002 Table 3	JEDEC JESD22 C101-C

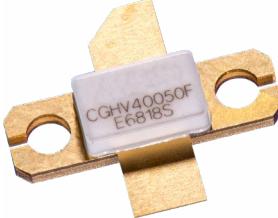
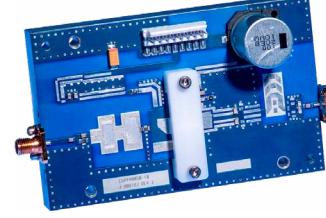
**Typical S-Parameters (Small Signal,  $V_{DS} = 50$  V,  $I_{DQ} = 300$  mA, magnitude / angle)**

Frequency	Mag S11	Ang S11	Mag S21	Ang S21	Mag S12	Ang S12	Mag S22	Ang S22
500 MHz	0.92	-161.97	13.79	79.27	0.01	-5.56	0.44	-142.42
600 MHz	0.92	-165.42	11.38	74.02	0.01	-9.73	0.46	-143.34
700 MHz	0.92	-168.02	9.62	69.31	0.01	-13.32	0.49	-144.16
800 MHz	0.93	-170.08	8.29	64.99	0.01	-16.49	0.52	-145.04
900 MHz	0.93	-171.8	7.24	60.98	0.009	-19.32	0.55	-146.01
1.0 GHz	0.93	-173.27	6.4	57.23	0.009	-21.83	0.58	-147.07
1.1 GHz	0.93	-174.58	5.7	53.71	0.009	-24.07	0.61	-148.21
1.2 GHz	0.94	-175.77	5.13	50.38	0.008	-26.05	0.63	-149.4
1.3 GHz	0.94	-176.86	4.64	47.24	0.008	-27.77	0.65	-150.62
1.4 GHz	0.94	-177.89	4.23	44.25	0.007	-29.25	0.67	-151.85
1.5 GHz	0.94	-178.87	3.87	41.42	0.007	-30.48	0.69	-153.09
1.6 GHz	0.94	-179.81	3.56	38.72	0.007	-31.46	0.71	-154.33
1.7 GHz	0.95	179.28	3.3	36.14	0.006	-32.19	0.73	-155.54
1.8 GHz	0.95	178.4	3.06	33.68	0.006	-32.66	0.74	-156.74
1.9 GHz	0.95	177.53	2.85	31.32	0.006	-32.85	0.76	-157.91
2.0 GHz	0.95	176.67	2.67	29.06	0.005	-32.75	0.77	-159.06
2.1 GHz	0.95	175.82	2.51	26.88	0.005	-32.33	0.78	-160.18
2.2 GHz	0.95	174.97	2.37	24.78	0.005	-31.57	0.79	-161.28
2.3 GHz	0.95	174.13	2.24	22.75	0.005	-30.43	0.8	-162.34
2.4 GHz	0.96	173.28	2.12	20.78	0.004	-28.87	0.81	-163.39
2.5 GHz	0.96	172.43	2.02	18.87	0.004	-26.86	0.82	-164.4
2.6 GHz	0.96	171.57	1.93	17.02	0.004	-24.35	0.82	-165.4
2.7 GHz	0.96	170.7	1.85	15.2	0.004	-21.31	0.83	-166.37
2.8 GHz	0.96	169.82	1.77	13.43	0.003	-17.72	0.84	-167.32
2.9 GHz	0.96	168.92	1.71	11.69	0.003	-13.6	0.84	-168.25
3.0 GHz	0.96	168.01	1.65	9.98	0.003	-8.98	0.85	-169.17
3.2 GHz	0.96	166.12	1.55	6.62	0.003	1.31	0.86	-170.95
3.4 GHz	0.96	164.13	1.47	3.33	0.003	11.88	0.86	-172.69
3.6 GHz	0.96	162	1.41	0.06	0.004	21.35	0.87	-174.4
3.8 GHz	0.95	159.72	1.36	-3.22	0.004	28.89	0.87	-176.09
4.0 GHz	0.95	157.25	1.33	-6.55	0.005	34.35	0.88	-177.76

To download the s-parameters in s2p format, go to the CGHV40050 Product Page.

**Product Dimensions CGHV40050F (Package Type – 440193)****Product Dimensions CGHV40050P (Package Type – 440206)**

**Product Ordering Information**

Order Number	Description	Unit of Measure	Image
CGHV40050F	GaN HEMT	Each	
CGHV40050P	GaN HEMT	Each	
CGHV40050F-AMP	Test board with GaN HEMT installed	Each	

## Notes & Disclaimer

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